Reference Material Certificate

526/01

Aluminium Base (Type of Standard)
AlMg, Set 520

Certified Values

Element	Mass content [%]	Uncertainty [%]
Silicon (Si)	0.155	± 0.007
Iron (Fe)	0.208	± 0.008
Copper (Cu)	0.0106	± 0.0005
Manganese (Mn)	0.300	± 0.010
Magnesium (Mg)	3.12	± 0.06
Chromium (Cr)	0.036	± 0.002
Nickel (Ni)	0.0060	± 0.0004
Zinc (Zn)	0.013	± 0.001
Titanium (Ti)	0.0156	± 0.0006
Beryllium (Be)	0.0006	± 0.0001
Bismuth (Bi)	0.0009	± 0.0002
Calcium (Ca)	0.0011	± 0.0001
Cadmium (Cd)	0.0012	± 0.0002
Cobalt (Co)	0.0006	± 0.0001
Gallium (Ga)	0.025	± 0.002
Sodium (Na)	0.0045	± 0.0003
Lead (Pb)	0.0019	± 0.0002
Tin (Sn)	0.0015	± 0.0002
Strontium (Sr)	0.0003	± 0.0001
Vanadium (V)	0.0105	± 0.0006
Zirconium (Zr)	0.0050	± 0.0005

The uncertainty reported is the result of standard deviation of all results multiplied with a factor of two and represents approximately the 95% confidence interval.

Manufacturing
This standard is produced using six strand hot top vertical continuous casting out of single melt.

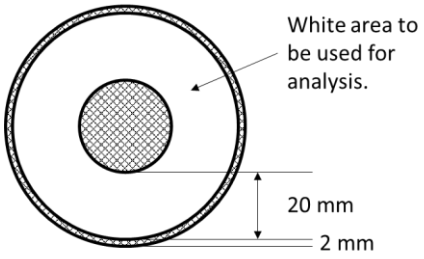
Homogeneity
Homogeneity testing is performed by means of spark emission spectroscopy. Tests involve making multiple measurements on individual samples taken at regular intervals along the entire length of each cast rod. Depending on the mass content of the element, the relative standard deviation of multiple measurements between discs or within one disc is typically found between 0.3% - 1% for alloying and other elements and 0.5% - 5% for trace elements.

Analysis
The values listed in this analysis certificate are the results of multiple analyses performed in our chemical analysis laboratory. The analyses are based on established wet chemical procedures.

Description of Sample
This reference material is available in the form of discs (approx. Ø 60 x 25 mm).

Intended use and Stability
This certified reference material is primarily intended for use in spark optical emission spectroscopy. Other applications are X-ray fluorescence spectrometry (XRF) and classical wet chemical procedures. The minimum sample size for wet chemical analysis is 0.2g. The material will remain stable for the period given below (certification validity) if it is stored in a dry and clean environment at room temperature.

Instructions for Use
Calibration measurements should be made within a ring between 2mm and 22mm from the edge of the CRM face. For wet chemical analysis chips have to be prepared by turning or milling of the sample surface.



Traceability
Traceability of the certified mass contents to the SI (Système International d'Unités) is ensured by calibration using certified standard solutions or pure metals or substances of known stoichiometry.

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